

CONTACT CLOSURE TEST SET

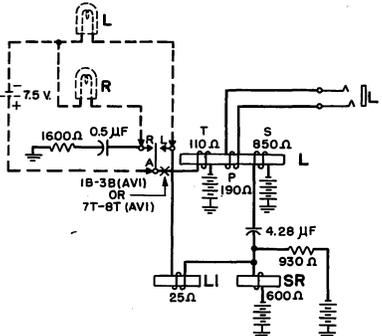
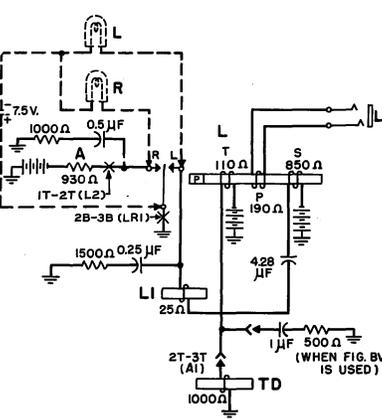
J94724A

1. GENERAL

1.001 This addendum supplements Section A702.019, Issue 2.

1.002 This addendum is issued to revise Table D to include circuit preparation in connection with Fig. 11 and 12.

Table D - Examples of Circuits Where DC Lamp Connection Can Be Used Only With Special Circuit Preparation

Fig. No.	Typical Circuit	Cause of Interference With Adjustment of Relay Under Test	Circuit Preparation Required To Permit Use of Contact Closure Test Set
11	<p>Test on Pri. wdg of L relay</p> 	<ol style="list-style-type: none"> <li>When the A and L contacts of L relay close, a surge through the 4.28 MF capacitor may affect the adjustment of the L relay.</li> <li>A surge through the tertiary winding from the 0.5 MF capacitor as the L relay makes or breaks the R contact may affect the relay adjustment.</li> </ol>	<ol style="list-style-type: none"> <li>Short the 4.28 MF capacitor.</li> <li>Insulate 1B-3B or 7T-8T of AV1 relay.</li> </ol>
12	<p>Test on Pri. wdg of L relay</p> 	<ol style="list-style-type: none"> <li>When the A and L contacts of L relay close, a surge through the 4.28 MF capacitor may affect the adjustment of the L relay.</li> <li>The R lamp will remain lighted on a circuit from ground on the armature, thru the 7.5-volt battery, the R lamp and the A resistor even though the A and R contacts of the L relay are open.</li> </ol>	<ol style="list-style-type: none"> <li>Short the 4.28 MF capacitor.</li> <li>Insulate 2B-3B of LR1 relay.</li> <li>Insulate 1T-2T of L2 relay.</li> </ol>